Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client

ATL (Auden)

Certificate No: D2000V2-1008_Feb06

CALIBRATION CERTIFICATE

Object

D2000V2 - SN:1008

Calibration procedure(s)

QA CAL-05.v6

Calibration procedure for dipole validation kits

Calibration date:

February 15, 2006

Condition of the calibrated item

In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).

The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility; environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	04-Oct-05 (METAS, No. 251-00516)	Oct-06
Power sensor HP 8481A	US37292783	04-Oct-05 (METAS, No. 251-00516)	Oct-06
Reference 20 dB Attenuator	SN: 5086 (20g)	11-Aug-05 (METAS, No 251-00498)	Aug-06
Reference 10 dB Attenuator	SN: 5047.2 (10r)	11-Aug-05 (METAS, No 251-00498)	Aug-06
Reference Probe ET3DV6	SN 1507	28-Oct-05 (SPEAG, No. ET3-1507_Oct05)	Oct-06
DAE4	SN 601	15-Dec-05 (SPEAG, No. DAE4-601_Dec05)	Dec-06
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (SPEAG, in house check Oct-05)	In house check: Oct-07
RF generator Agilent E4421B	MY41000675	11-May-05 (SPEAG, in house check Nov-05)	In house check: Nov-07
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (SPEAG, in house check Nov-05)	In house check: Nov-06
	Name	Function	Signature
Calibrated by:	Judith Müller	Laboratory Technician	mullinge
Approved by:	Katja Pokovic	Technical Manager	Z. Kg

Issued: February 15, 2006

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL

tissue simulating liquid

ConvF

sensitivity in TSL / NORM x,y,z

N/A

not applicable or not measured

Calibration is Performed According to the Following Standards:

 IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003

 b) CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz),

July 2001

c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end
 of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
 point exactly below the center marking of the flat phantom section, with the arms oriented
 parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
 positioned under the liquid filled phantom. The impedance stated is transformed from the
 measurement at the SMA connector to the feed point. The Return Loss ensures low
 reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.6
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Area Scan resolution	dx, dy = 15 mm	
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	2000 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.2 ± 6 %	1.46 mho/m ± 6 %
Head TSL temperature during test	(22.0 ± 0.2) °C		

SAR result with Head TSL

SAR averaged over 1 cm³ (1 g) of Head TSL	condition	
SAR measured	250 mW input power	11.1 mW/g
SAR normalized	normalized to 1W	44.4 mW / g
SAR for nominal Head TSL parameters 1	normalized to 1W	43.0 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm3 (10 g) of Head TSL	condition	
SAR measured	250 mW input power	5.69 mW / g
SAR normalized	normalized to 1W	22.8 mW / g
SAR for nominal Head TSL parameters 1	normalized to 1W	22.4 mW / g ± 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	53.3	1.52 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	51.9 ± 6 %	1.58 mho/m ± 6 %
Body TSL temperature during test	(22.1 ± 0.2) °C		-

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	condition	
SAR measured	250 mW input power	11.0 mW /g
SAR normalized	normalized to 1W	44.0 mW /g
SAR for nominal Body TSL parameters ²	normalized to 1W	42.3 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	Condition	
SAR measured	250 mW input power	5.70 mW /g
SAR normalized	normalized to 1W	22.8 mW /g
SAR for nominal Body TSL parameters 2	normalized to 1W	22.2 mW / g ± 16.5 % (k=2)

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	51.6 Ω - 0.8 jΩ	
Return Loss	- 34.8 dB	

Antenna Parameters with Body TSL

Impedance, transformed to feed point	46.4 Ω - 0.1 Ω	
Return Loss	- 28.5 dB	

General Antenna Parameters and Design

Electrical Delay (one direction)	1.189 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG	
Manufactured on	May 27, 2003	

Certificate No: D2000V2-1008_Feb06

DASY4 Validation Report for Head TSL

Date/Time: 14.02.2006 15:40:05

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 2000 MHz; Type: D2000V2; Serial: D2000V2 - SN:1008

Communication System: CW; Frequency: 2000 MHz; Duty Cycle: 1:1

Medium: HSL 2000MHz;

Medium parameters used: f = 2000 MHz; $\sigma = 1.47$ mho/m; $\varepsilon_r = 39.2$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

Probe: ET3DV6 - SN1507 (HF); ConvF(4.55, 4.55, 4.55); Calibrated: 28.10.2005

Sensor-Surface: 4mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 15.12.2005

Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; ;

Measurement SW: DASY4, V4.6 Build 56; Postprocessing SW: SEMCAD, V1.8 Build 160

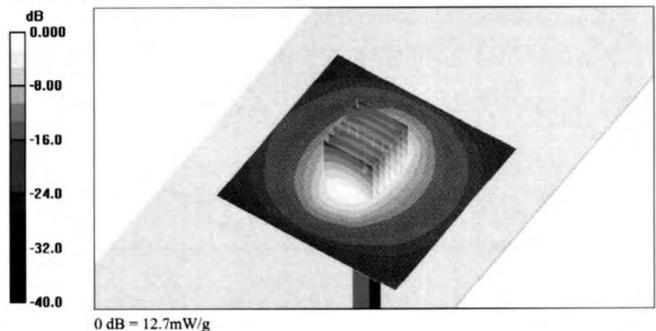
Pin = 250 mW; d = 10 mm/Area Scan (71x71x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (interpolated) = 13.4 mW/g

Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

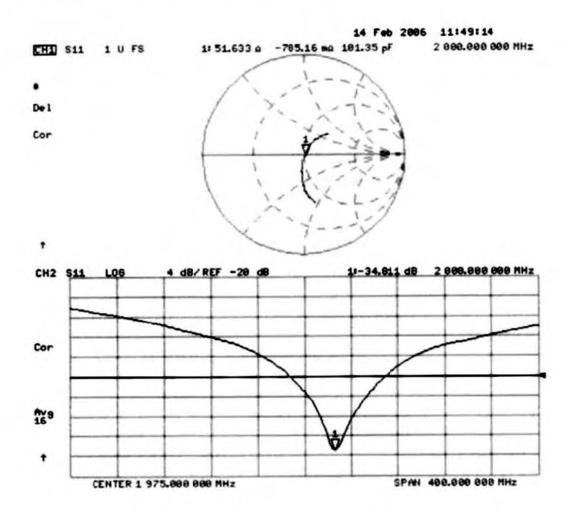
Reference Value = 97.3 V/m; Power Drift = 0.008 dB

Peak SAR (extrapolated) = 19.7 W/kg

SAR(1 g) = 11.1 mW/g; SAR(10 g) = 5.69 mW/gMaximum value of SAR (measured) = 12.7 mW/g



Impedance Measurement Plot for Head TSL



DASY4 Validation Report for Body TSL

Date/Time: 15.02.2006 11:11:23

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 2000 MHz; Type: D2000V2; Serial: 1008

Communication System: CW-2000; Frequency: 2000 MHz; Duty Cycle: 1:1

Medium: MSL 2000 MHz;

Medium parameters used: f = 2000 MHz; $\sigma = 1.58$ mho/m; $\epsilon_r = 51.9$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

Probe: ET3DV6 - SN1507 (HF); ConvF(4.22, 4.22, 4.22); Calibrated: 28.10.2005

Sensor-Surface: 4mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 15.12.2005

Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; ;

Measurement SW: DASY4, V4.6 Build 56; Postprocessing SW: SEMCAD, V1.8 Build 160

Pin = 250 mW; d = 10 mm/Area Scan (81x81x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (interpolated) = 12.5 mW/g

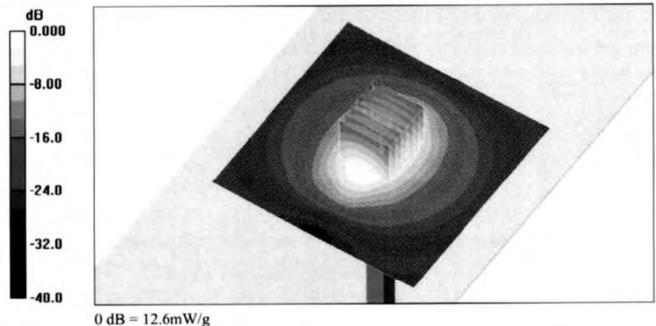
Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 94.3 V/m; Power Drift = -0.001 dB

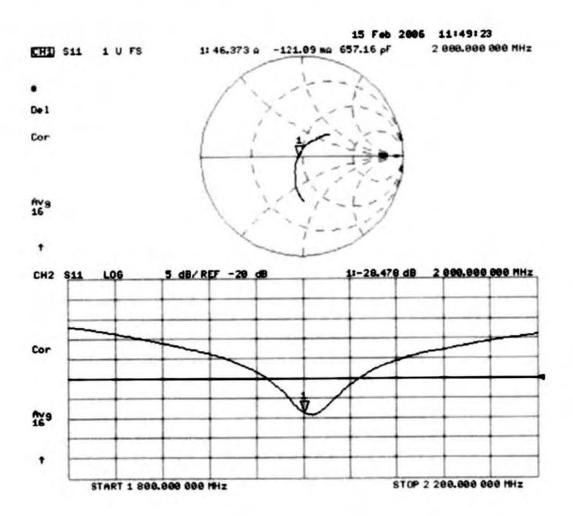
Peak SAR (extrapolated) = 20.0 W/kg

SAR(1 g) = 11 mW/g; SAR(10 g) = 5.7 mW/g

Maximum value of SAR (measured) = 12.6 mW/g



Impedance Measurement Plot for Body TSL



Calibration Laboratory of

Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura

S Swiss Calibration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client

ATL (Auden)

Certificate No: ET3-1530_Sep05

CALIBRATION CERTIFICATE

Object

ET3DV6 - SN:1530

Calibration procedure(s)

QA CAL-01.v5 and QA CAL-12.v4

Calibration procedure for dosimetric E-field probes

Calibration date:

September 6, 2005

Condition of the calibrated item

In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).

The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	3-May-05 (METAS, No. 251-00466)	May-06
Power sensor E4412A	MY41495277	3-May-05 (METAS, No. 251-00466)	May-06
Power sensor E4412A	MY41498087	3-May-05 (METAS, No. 251-00466)	May-06
Reference 3 dB Attenuator	SN: S5054 (3c)	11-Aug-05 (METAS, No. 251-00499)	Aug-06
Reference 20 dB Attenuator	SN: S5086 (20b)	3-May-05 (METAS, No. 251-00467)	May-06
Reference 30 dB Attenuator	SN: S5129 (30b)	11-Aug-05 (METAS, No. 251-00500)	Aug-06
Reference Probe ES3DV2	SN: 3013	7-Jan-05 (SPEAG, No. ES3-3013_Jan05)	Jan-06
DAE4	SN: 654	29-Nov-04 (SPEAG, No. DAE4-654_Nov04)	Nov-05
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (SPEAG, in house check Dec-03)	In house check: Dec-05
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Nov-04)	In house check: Nov 05
	Name	Function	Signature
Calibrated by:	Nico Vetterli	Laboratory Technician	0.16/10
Approved by:	Katja Pokovic	Technical Manager	Mar- Kaly

Issued: September 6, 2005

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kallbrierdienst

C Service suisse d'étalonnage Servizio svizzero di taratura

S Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL tissue simulating liquid NORMx,y,z sensitivity in free space

ConF sensitivity in TSL / NORMx,y,z
DCP diode compression point
Polarization φ rotation around probe axis

Polarization 9 9 rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., $\theta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003

 b) CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz), July 2001

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 9 = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a
 flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

ET3DV6 SN:1530

Probe ET3DV6

SN:1530

Manufactured: July 15, 2000

Last calibrated: September 1, 2004 Repaired: August 26, 2005

Recalibrated: September 6, 2005

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: ET3-1530_Sep05

DASY - Parameters of Probe: ET3DV6 SN:1530

Sensitivity in Free Space ^A			Diode C	compression ^B
NormX	1.40 ± 10.1%	$\mu V/(V/m)^2$	DCP X	94 mV
NormY	1.49 ± 10.1%	$\mu V/(V/m)^2$	DCP Y	94 mV
NormZ	1.49 ± 10.1%	$\mu V/(V/m)^2$	DCP Z	94 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 900 MHz Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	8.9	5.0
SAR _{be} [%]	With Correction Algorithm	0.0	0.2

TSL 1810 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	13.5	9.1
SAR [%]	With Correction Algorithm	0.9	0.0

Sensor Offset

Probe Tip to Sensor Center 2.7 mm

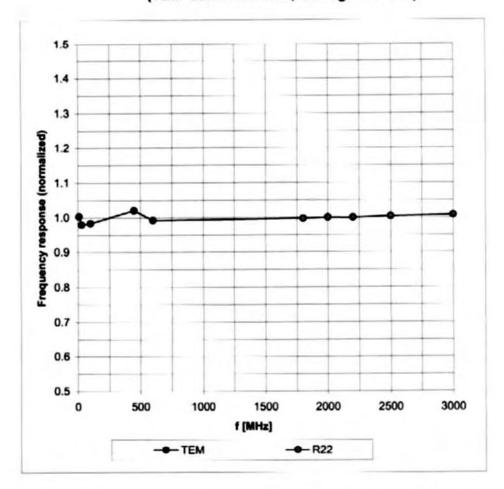
The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

A The uncertainties of NormX,Y,Z do not affect the E2-field uncertainty inside TSL (see Page 8).

⁸ Numerical linearization parameter: uncertainty not required.

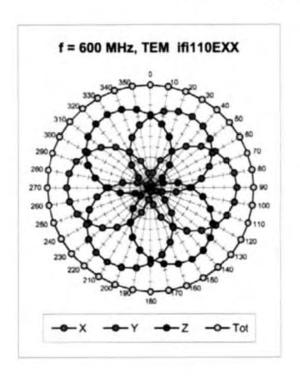
Frequency Response of E-Field

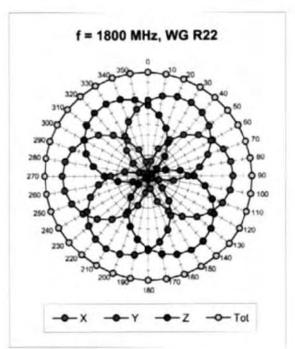
(TEM-Cell:ifi110 EXX, Waveguide: R22)

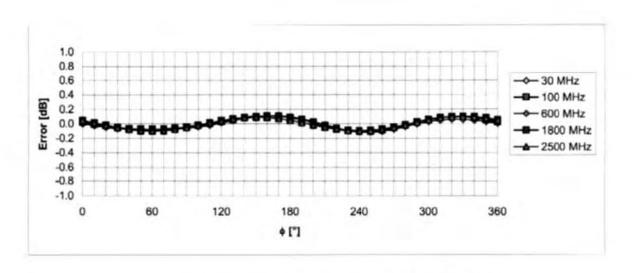


Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Receiving Pattern (ϕ), θ = 0°



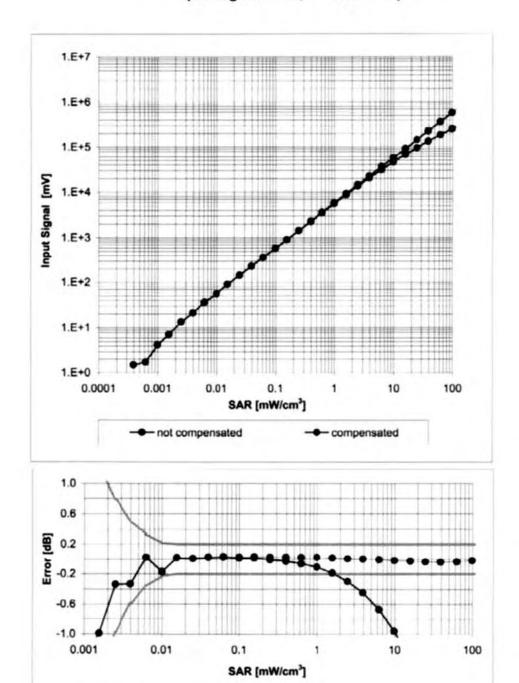




Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

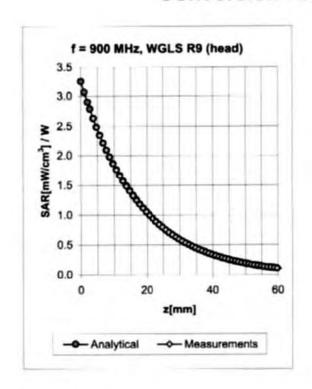
Dynamic Range f(SAR_{head})

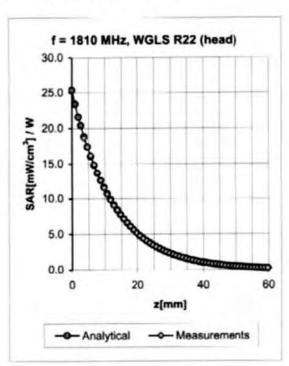
(Waveguide R22, f = 1800 MHz)



Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Conversion Factor Assessment



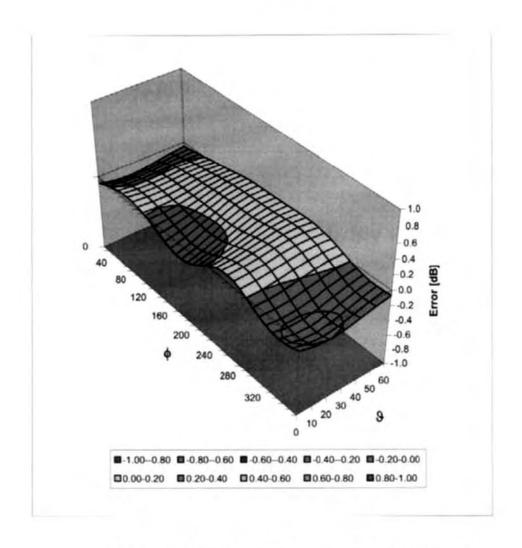


f [MHz]	Validity [MHz] ^C	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
450	± 50 / ± 100	Head	43.5 ± 5%	0.87 ± 5%	0.02	1.10	6.50 ± 13.3% (k=2)
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	0.51	2.00	5.90 ± 11.0% (k=2)
1810	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.59	2.42	4.98 ± 11.0% (k=2)
2000	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.59	2.54	4.62 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.71	2.14	4.33 ± 11.8% (k=2)
450	±50/±100	Body	56.7 ± 5%	0.94 ± 5%	0.01	2.40	6.86 ± 13.3% (k=2)
900	±50/±100	Body	55.0 ± 5%	1.05 ± 5%	0.54	2.06	5.85 ± 11.0% (k=2)
1810	±50/±100	Body	53.3 ± 5%	1.52 ± 5%	0.57	2.69	4.32 ± 11.0% (k=2)
2000	±50/±100	Body	53.3 ± 5%	1.52 ± 5%	0.62	2.47	4.13 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.86	1.69	4.07 ± 11.8% (k=2)

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Deviation from Isotropy in HSL

Error (φ, θ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura **Swiss Calibration Service**

Accredited by the Swiss Federal Office of Metrology and Accreditation The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Accreditation No.: SCS 108

C

Client

ATL (Auden)

Certificate No: DAE3-393 Apr06

CALIBRATION CERTIFICATE

Object

DAE3 - SD 000 D03 AA - SN: 393

Calibration procedure(s)

QA CAL-06.v12

Calibration procedure for the data acquisition electronics (DAE)

Calibration date:

April 21, 2006

Condition of the calibrated item

In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	7-Oct-05 (Sintrel, No.E-050073)	Oct-06
Secondary Standards	ID#	Check Date (in house)	Scheduled Check

Calibrated by:

Name

Function

Signature

Eric Hainfeld

Technician

Approved by:

Fin Bomholt

R&D Director

Issued: April 21, 2006

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: DAE3-393 Apr06

Page 1 of 5

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
S Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Glossary

DAE

data acquisition electronics

Connector angle

information used in DASY system to align probe sensor X to the robot

coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters contain technical information as a result from the performance test and require no uncertainty.
- DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
- Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
- Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
- AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
- Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
- Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
- Input resistance: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
- Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
- Power consumption: Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range:

1LSB =

6.1µV.

full range = -100...+300 mV

Low Range:

1LSB =

61nV .

full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	403.993 ± 0.1% (k=2)	404.247 ± 0.1% (k=2)	404.157 ± 0.1% (k=2)
Low Range	3.96983 ± 0.7% (k=2)	3.95192 ± 0.7% (k=2)	3.95323 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	18°±1°
Connector Angle to be used in DASY system	10.

Certificate No: DAE3-393_Apr06

Page 3 of 5

Appendix

1. DC Voltage Linearity

High Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	200000	199999.8	0.00
Channel X + Input	20000	20006.39	0.03
Channel X - Input	20000	-19998.72	-0.01
Channel Y + Input	200000	200000.1	0.00
Channel Y + Input	20000	20002.96	0.01
Channel Y - Input	20000	-19996.65	-0.02
Channel Z + Input	200000	200000.6	0.00
Channel Z + Input	20000	20002.7	0.01
Channel Z - Input	20000	-20007.82	0.04

Low Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	2000	2000	0.00
Channel X + Input	200	199.88	-0.06
Channel X - Input	200	-200.30	0.15
Channel Y + Input	2000	1999.9	0.00
Channel Y + Input	200	199.28	-0.36
Channel Y - Input	200	-200.88	0.44
Channel Z + Input	2000	2000.1	0.00
Channel Z + Input	200	199.13	-0.44
Channel Z - Input	200	-201.04	0.52

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	12.55	11.71
	- 200	-10.47	-11.43
Channel Y	200	10.20	9.56
	- 200	-10.84	-11.35
Channel Z	200	3.40	3.07
	- 200	-4.91	-5.25

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200		1.93	0.47
Channel Y	200	0.95	,	5.88
Channel Z	200	-1.31	1.19	

Certificate No: DAE3-393_Apr06 Page 4 of 5

	High Range (LSB)	Low Range (LSB)
Channel X	16147	16455
Channel Y	16015	16455
Channel Z	16449	17189

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	0.19	-1.26	0.85	0.29
Channel Y	-1.55	-2.64	-0.70	0.34
Channel Z	-0.95	-2.22	1.82	0.54

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)	
Channel X	0.2000	198.7	
Channel Y	0.2001	198.6	
Channel Z	0.1999	198.5	

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9